Refine Search

Search Results -

Terms	Documents
L31	0

Database:

> US Pre-Grant Publication Full-Text Database
> US Patents Full-Text Database
> US OCR Full-Text Database
> EPO Abstracts Database
> JPO Abstracts Database
> Derwent World Patents Index
> IBM Technical Disclosure Bulletins

Search:

> L32

[Refine Search]

[Recall Text] [Clear] [Interrupt]

Search History

DATE: Thursday, December 23, 2004   Printable Copy   Create Case

Set Name	Query	Hit Count	Set Name
side by side			result set
	DB=TDBD; PLUR=YES; OP=OR		
L32	L31	0	L32
	DB=DWPI; PLUR=YES; OP=OR		
L31	L30	0	L31
	DB=JPAB; PLUR=YES; OP=OR		
L30	L29	0	L30
	DB=EPAB; PLUR=YES; OP=OR		
L29	L28	0	L29
	DB=USOC; PLUR=YES; OP=OR		
L28	L27	0	L28
	DB=PGPB; PLUR=YES; OP=OR		
L27	L26	0	L27
	DB=USPT; PLUR=YES; OP=OR		
L26	L25 and (gate near6 fin)	11	L26
L25	L24 and (nitride near5 oxide)	14	L25

L24	L19 near8 ("oxide" near5 top)	19	L24
L23	L21 and (gate near7 fin)	83	L23
L22	L21 and (gate same ("top surface" near4 "bottom surface"))	13	L22
L21	L20 and nitride	1805	L21
L20	L19 and "oxide"	6784	L20
L19	"fin"	56874	L19
L18	"GERMANIUM FIN"	0	L18
L17	L15	0	L17

DB=TDBD; PLUR=YES; OP=OR

| L16 | L15 | 0 | L16 |

DB=DWPI; PLUR=YES; OP=OR

| L15 | L14 | 0 | L15 |

DB=JPAB; PLUR=YES; OP=OR

| L14 | L13 | 0 | L14 |

DB=EPAB; PLUR=YES; OP=OR

| L13 | "high breakdown" and "ratio of increase" | 0 | L13 |

DB=USOC; PLUR=YES; OP=OR

| L12 | L11 | 0 | L12 |

DB=PGPB; PLUR=YES; OP=OR

| L11 | L10 | 0 | L11 |

DB=USPT; PLUR=YES; OP=OR

L10	"high breakdown" and "ratio of increase"	0	L10
L9	6040598	1	L9
L8	L7 and fiber	1	L8
L7	L6 and control$5	2	L7
L6	L4 and (plasma near4 damage)	2	L6
L5	L4 and "plasma damage"	1	L5
L4	L3 and (charg$5 near5 wafer)	23	L4
L3	L2 and ("spectrometer" near6 (optical near emission$))	69	L3
L2	"plasma chamber"	4013	L2
L1	6673200	1	L1

END OF SEARCH HISTORY